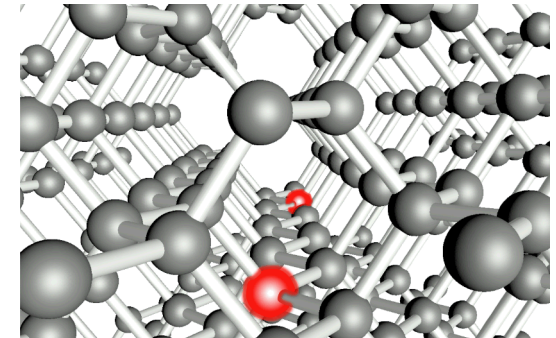
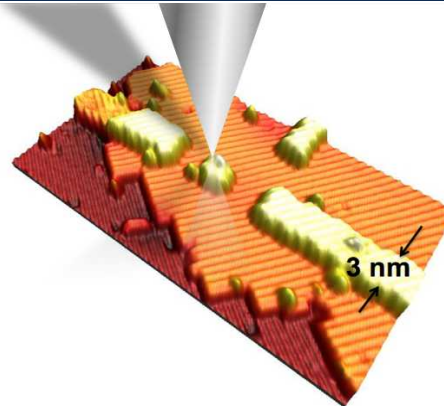
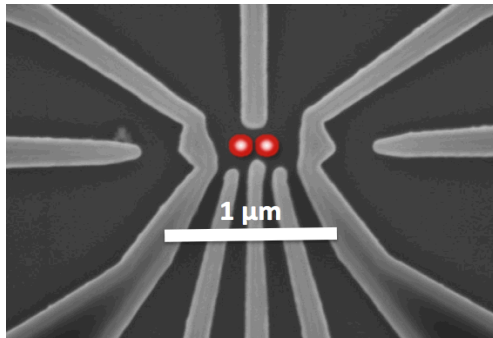


Exceptional service in the national interest



Donor charge qubits via STM assisted fabrication

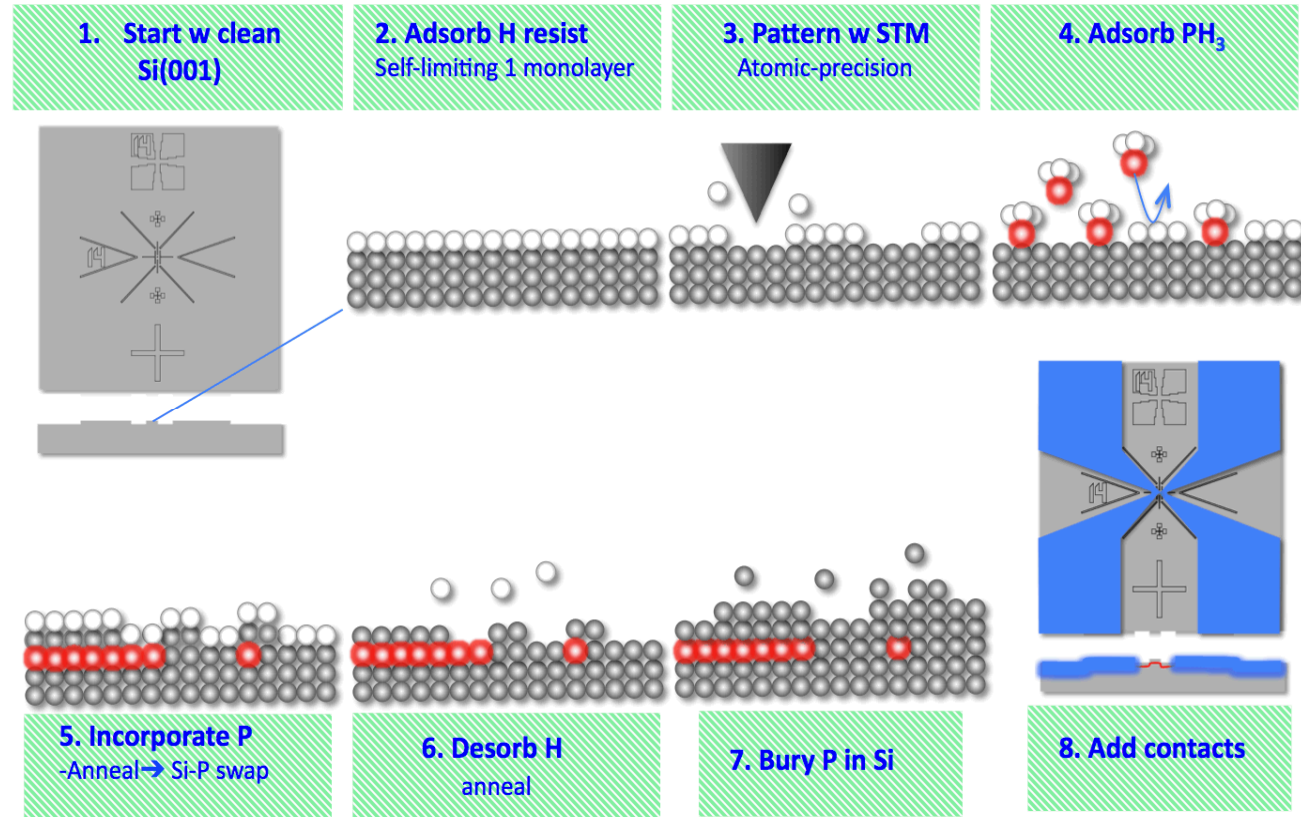
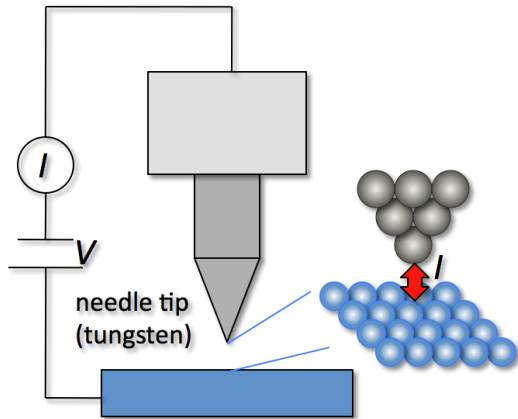
Ezra Bussmann (ebussma@sandia.gov) J. Dominguez,
S.Carr, T.-M. Lu, E. Nielsen, R. Rahman, T. Jacobson, W. Witzel, G.
Ten Eyck, M. P. Lilly, M. S. Carroll

Talk overview

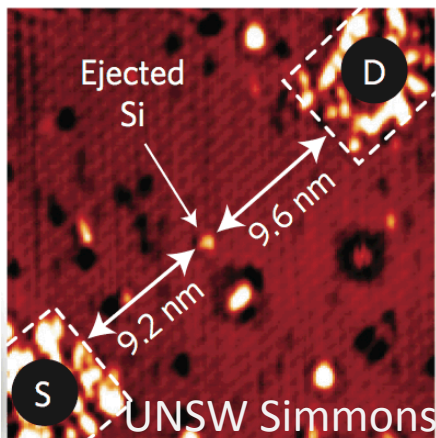
- I. Quick review of Scanning Tunneling Microscopy (STM) Fabrication
- II. Review of progress report at 2nd EAB (October 2011)
- III. **New results since the 2nd EAB**
 - Completed new cleanroom lab for STM assisted fab***
 - Reproduced Simmons qubit fabrication steps in lab***
 - Performed design & modeling of qubit***
- IV. Present work: demonstrate a working atomic-precision device

STM assisted fab overview

- STM : an atomic resolution surface imaging and manipulation tool

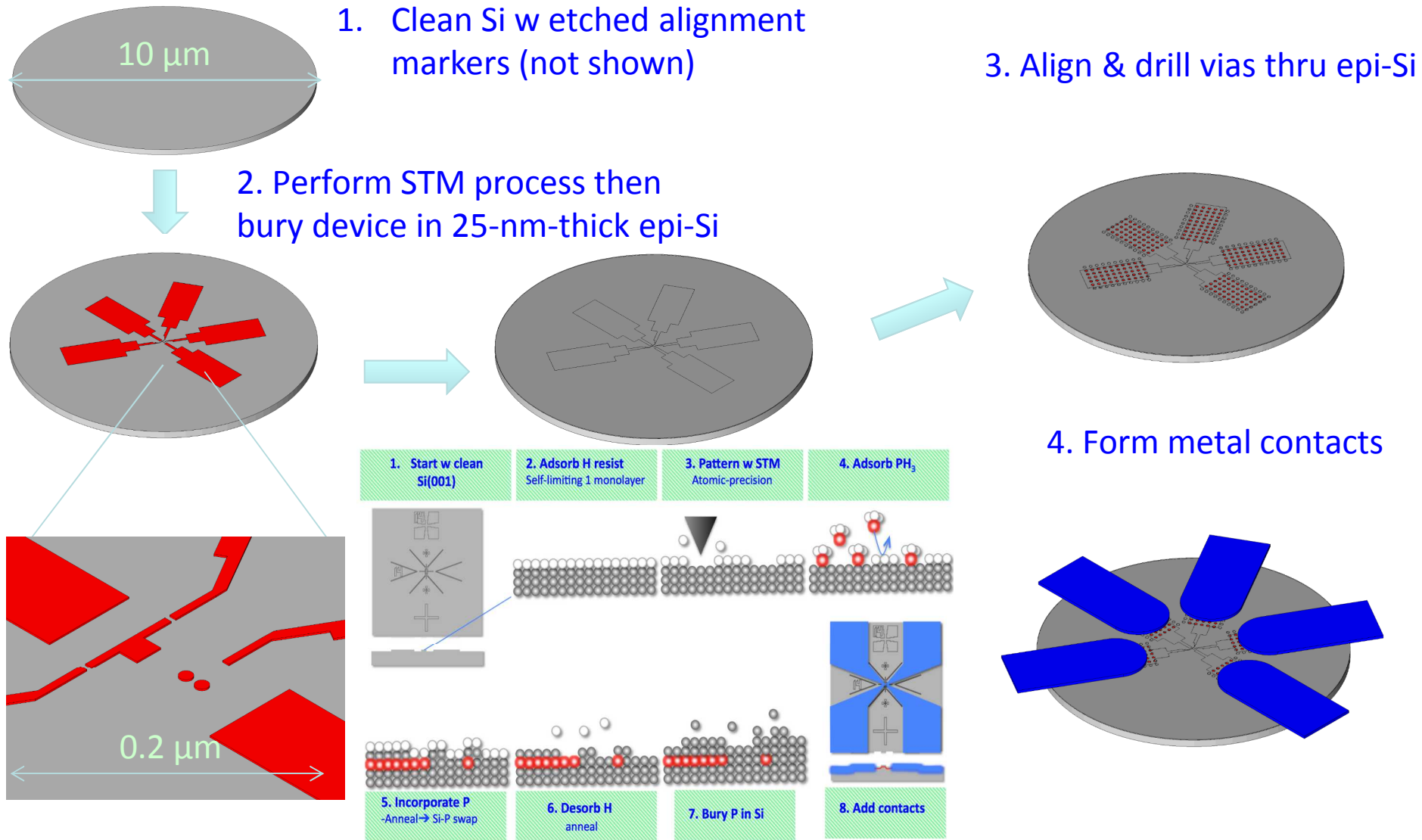


Single P atom transistor in Si



1. M.Y. Simmons et al.
2. F.J. Ruess et al. Nano Letters (2004)
3. M.Fuechle et al. Nature Nanotech (2012)

Target device: donor charge qubit



- Objective: demonstrate fabrication of single charge qubit

Milestones for STM fab

- Year 1
 - Recover old STM chamber outside of clean room for non-toxic gas experiments
 - Design clean room STM (includes phosphine capability)
 - Build clean room STM (Including PH₃, labspace, etc)
 - Show clean hydrogen terminated surface and local removal with STM tip
- Year 2
 - Establish capability to pattern large areas (long tip lifetime)
 - Connection to large area contacts (n+ or Al spike)
 - Silicon encapsulation of phosphorus
 - Incorporation of phosphorus on surface
 - Demonstrate initial transport test devices (wires)
 - Demonstrate single donor placement
- Year 3
 - Demonstrate two donor placement
 - Demonstrate transport through double donor
 - Develop charge sensor for two donor system
 - Demonstrate qubit

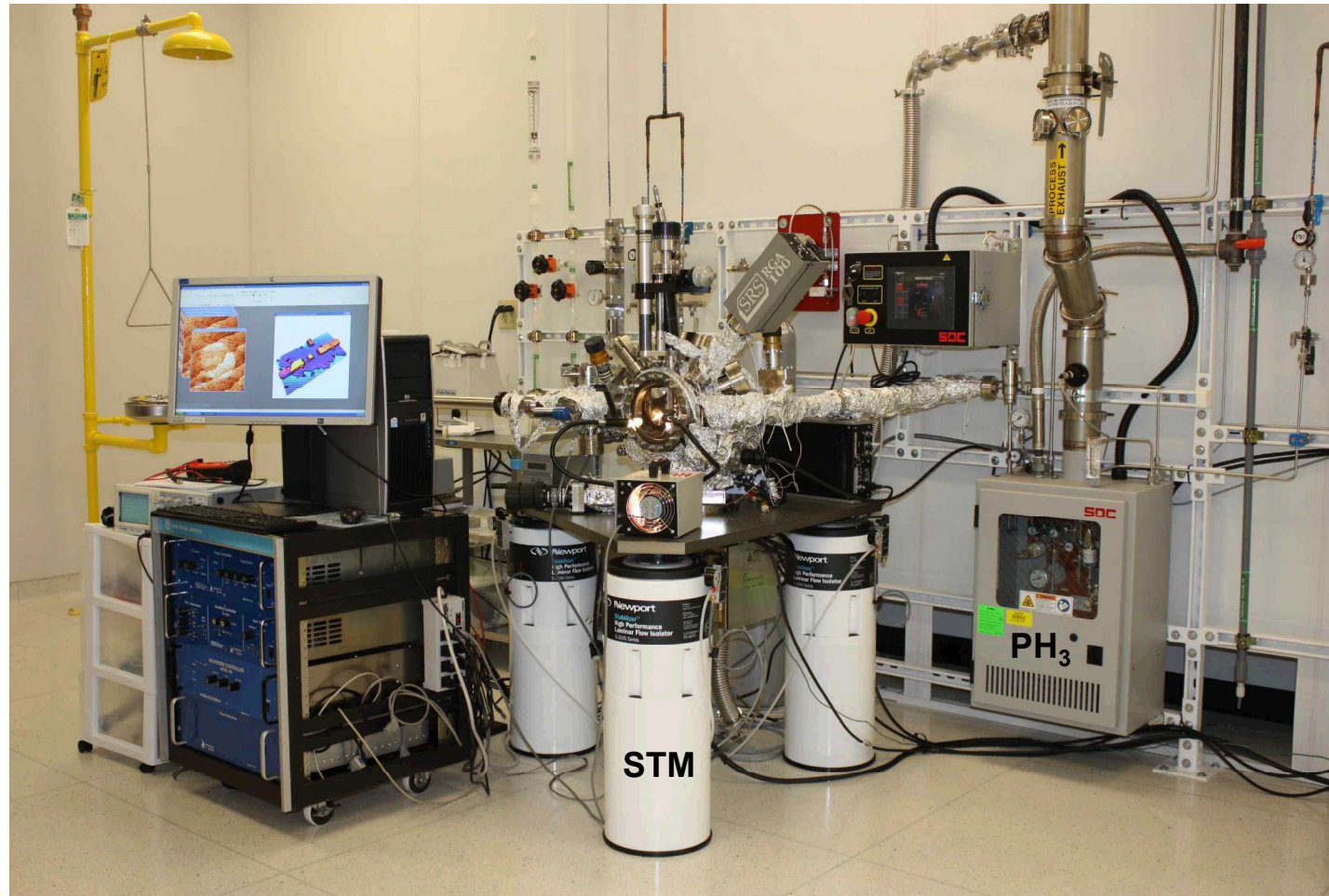
Milestones for STM fab

- Year 1
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 - ✓ Silicon encapsulation of phosphorus
 - ✓ Incorporation of phosphorus on surface
 - ✓ **Demonstrate initial transport test devices (wires) (Macroscopic Hall effect devices)**
 - Demonstrate single donor placement
- Year 3
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 - Demonstrate transport through double donor
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Completed new lab in cleanroom

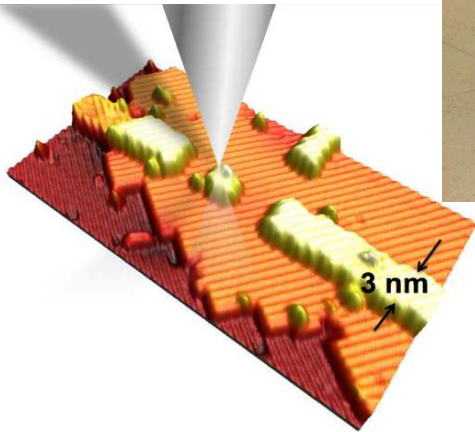


8/2011



5/2012

(7/2011-5/2012)

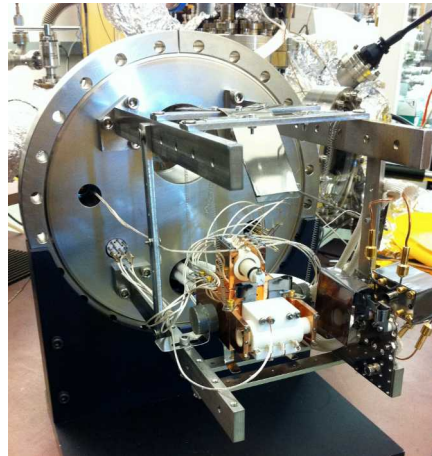


Completion of new STM for Si fab process

(mid-2011-3/2012)



11/2011



1/2012

New STM head w/ X-Y-Z motion
and line-of-sight to sample

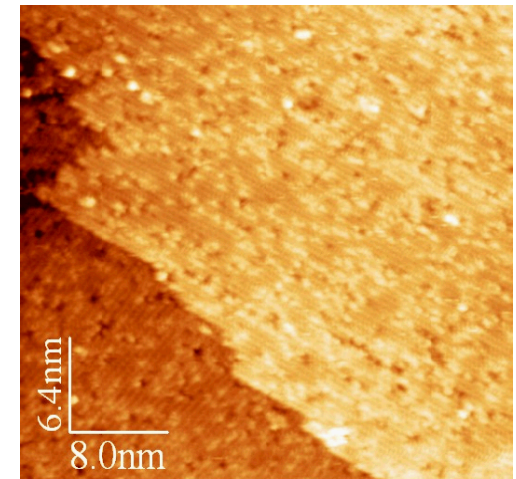
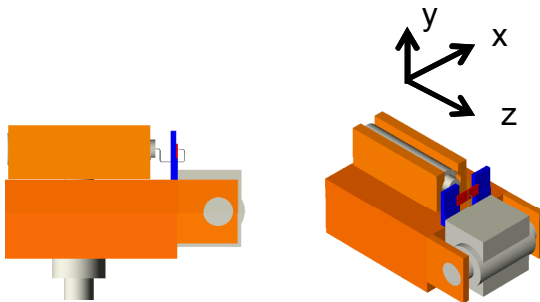


Image obtained w new STM (3/2012)
near-atomic resolution

Progress on fabrication steps

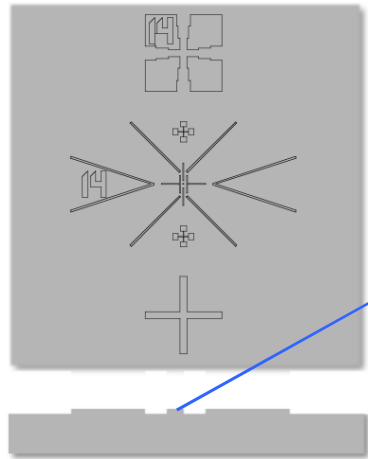
1st EAB

1. Start w clean Si(001)

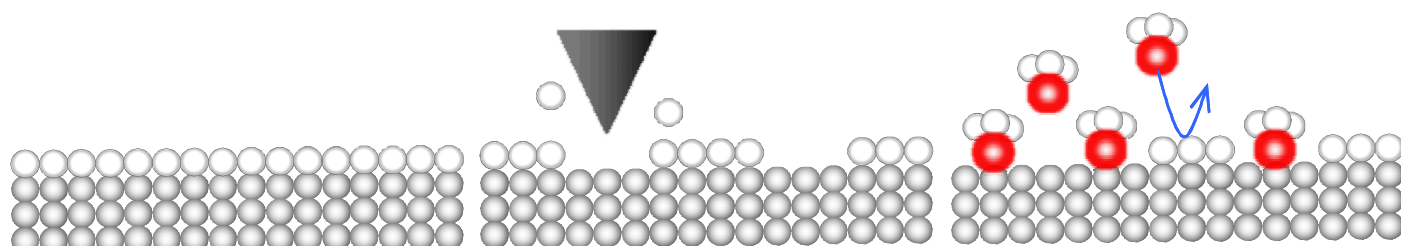
2. Adsorb H resist
Self-limiting 1 monolayer

3. Pattern w STM
Atomic-precision

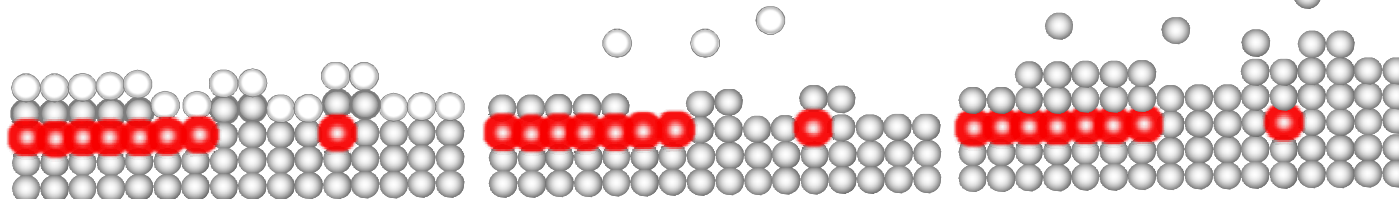
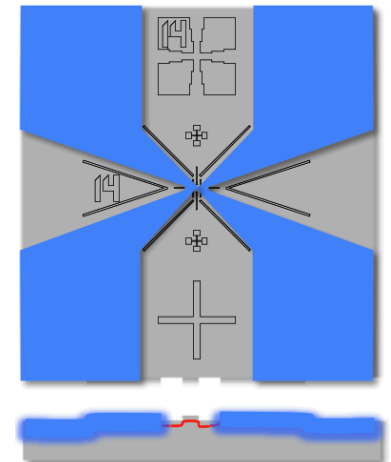
4. Adsorb PH_3



Etched alignment marks
J. Dominguez



Al depo+liftoff
J. Dominguez



5. Incorporate P
-Anneal \rightarrow Si-P swap
-H resist constrains P

6. Desorb H
anneal

7. Bury P in Si

8. Add contacts

Progress on fabrication steps

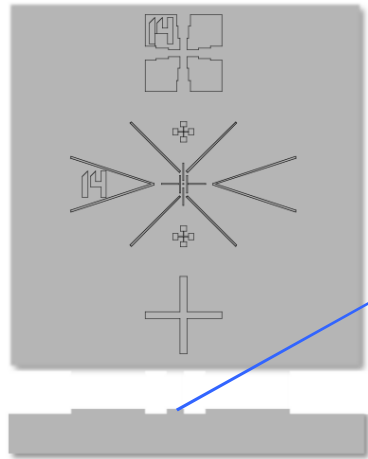
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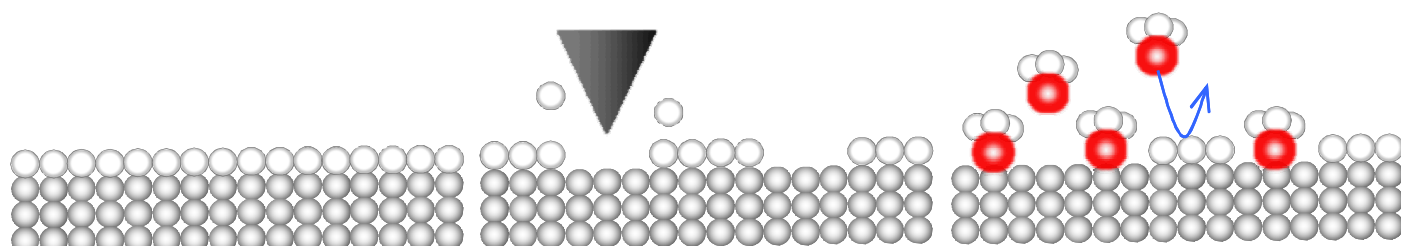
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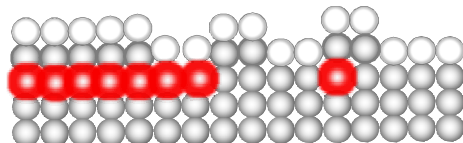
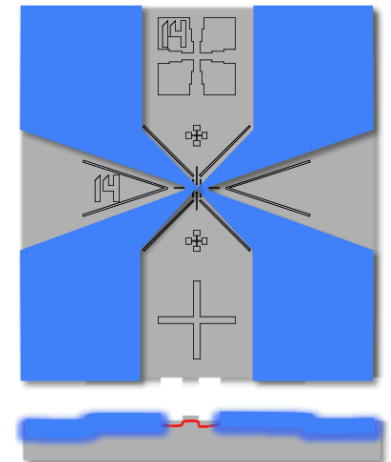
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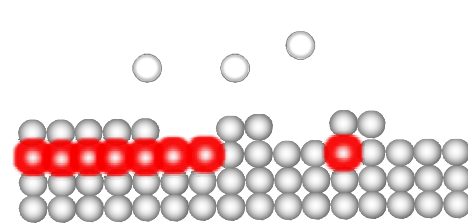
Etched alignment marks
J. Dominguez



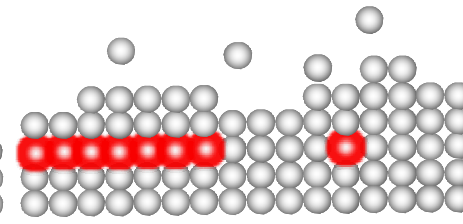
Al depo+liftoff
J. Dominguez



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-Anneal \rightarrow Si-P swap



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anneal



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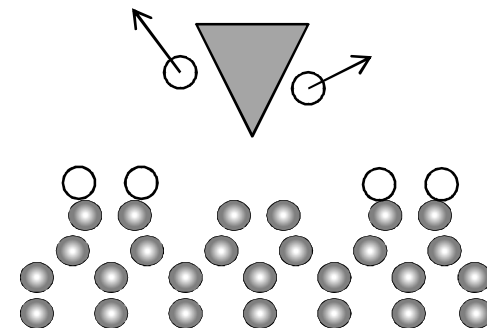
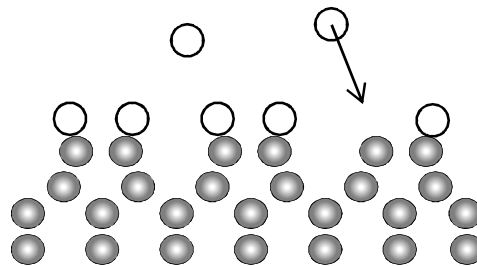
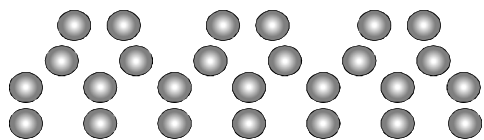
Progress on fabrication steps

1. Prepare clean Si(001) (10-11/2010)

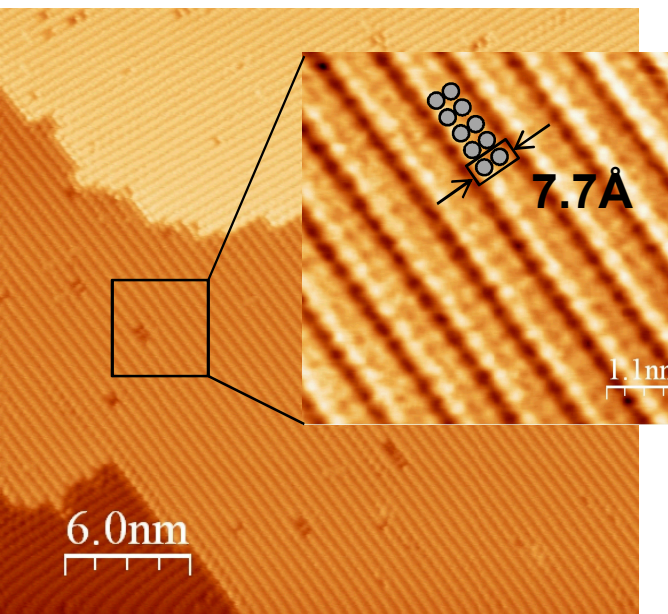
2. Low-defect H resist layers (11/2010)

3. Atomic-precision windows in resist (12/2010)

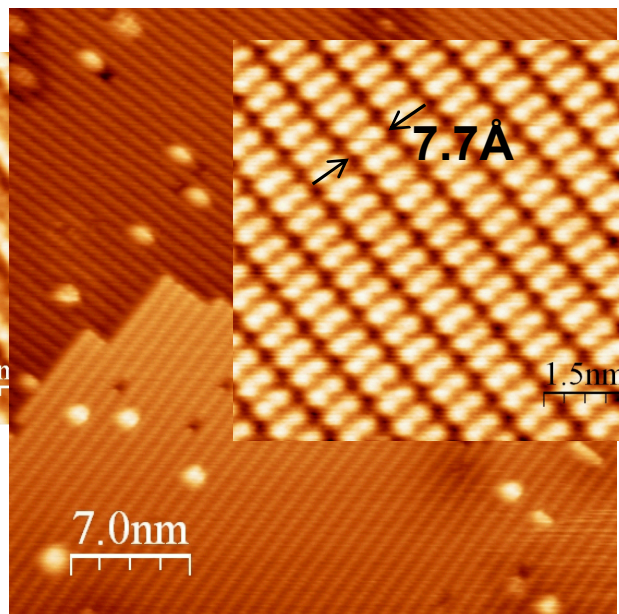
side views



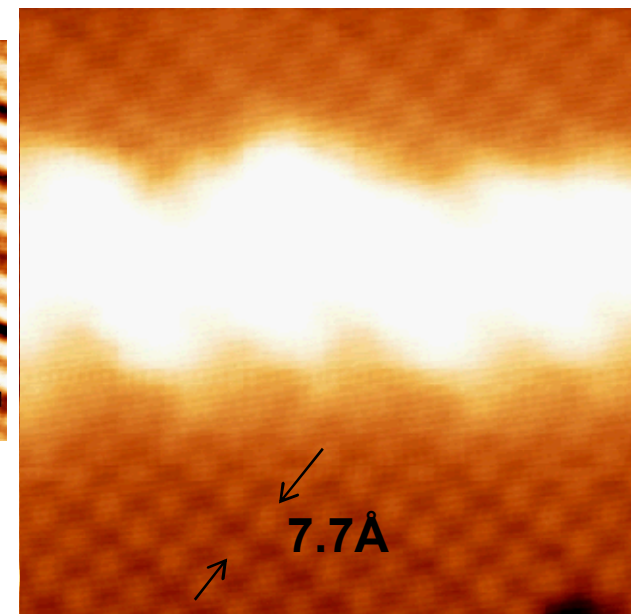
top views



Si(100)-2x1



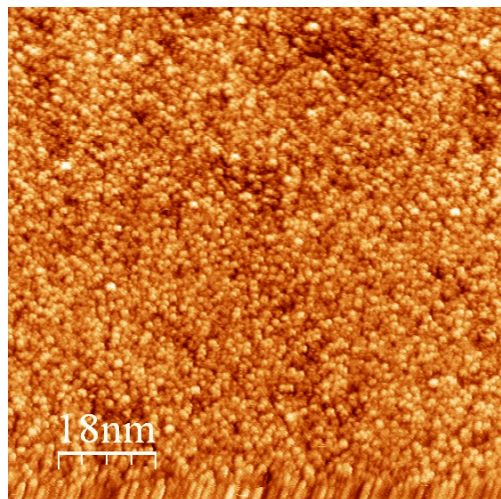
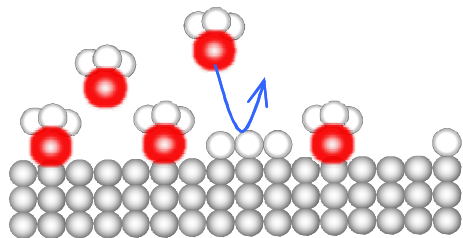
Si(100)-2x1-monohydride



Progress on fabrication steps

4. Adsorb PH_3 (3/2011-1/2012)

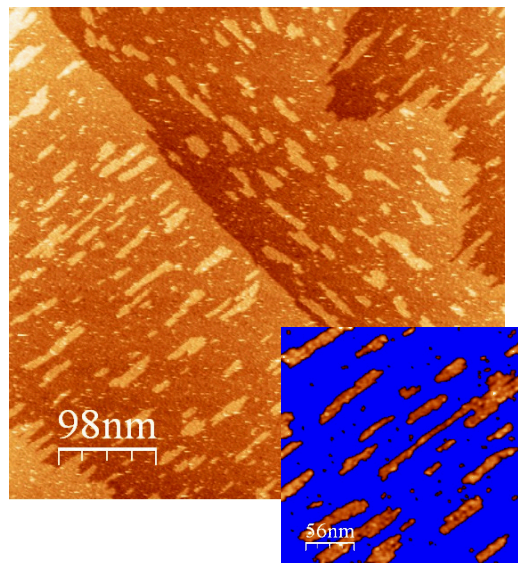
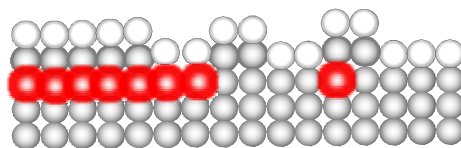
- Expose to PH_3 gas



Mixed phase of H/PH_x
On Si surface

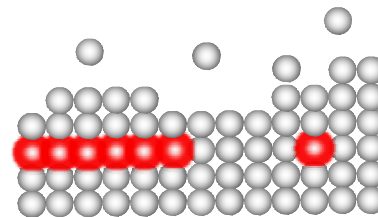
5. Incorporate P into Si (2-4/2012)

- Anneal 350C-500C

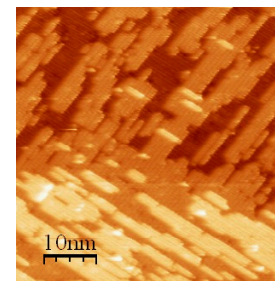


P incorporates into
Si \rightarrow Si ejected to surface
Forming Si islands

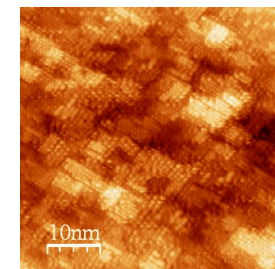
6. Bury device in epi-Si (1/2011-2/2011)



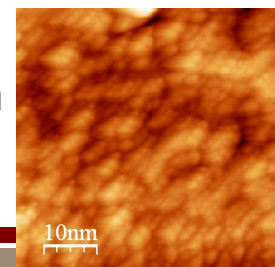
0.7 ML



40 ML
~5 nm



80 ML
~10 nm

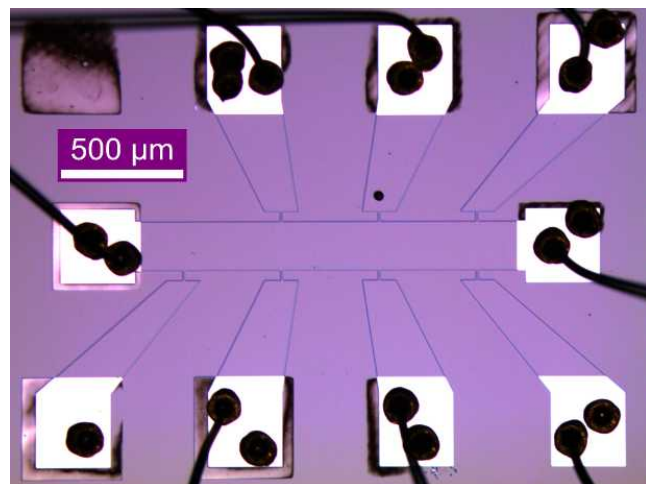


Thicker Si growth \rightarrow rougher surface

Initial transport test devices

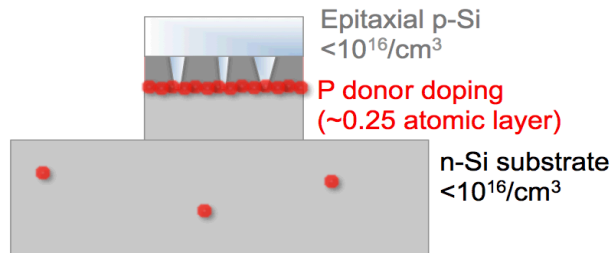
(4/2012 - 5/2012)

Trench isolated Hall device



SANDIA

Contacts Al



- Extract e- density & mobility from longitudinal R_{xx} and transverse R_{xy} Hall resistance

Electron density and mobility at T=4K

| Device | e- density n_e 10^{14} /cm ² | e- mobility cm ² /Vs |
|--------|---|---------------------------------|
| 1 | 0.7 | 127 |
| 2 | 0.7 | 143 |
| 3 | 1.2 | 122 |

- Similar Hall effect devices from Simmons yielded $n = 1.2\text{--}1.7 \times 10^{14}/\text{cm}^2$ mobility < 100 cm²/Vs

- Donor and electron density sufficient for atomic precision devices
- Next step: implement complete atomic-precision fab technique

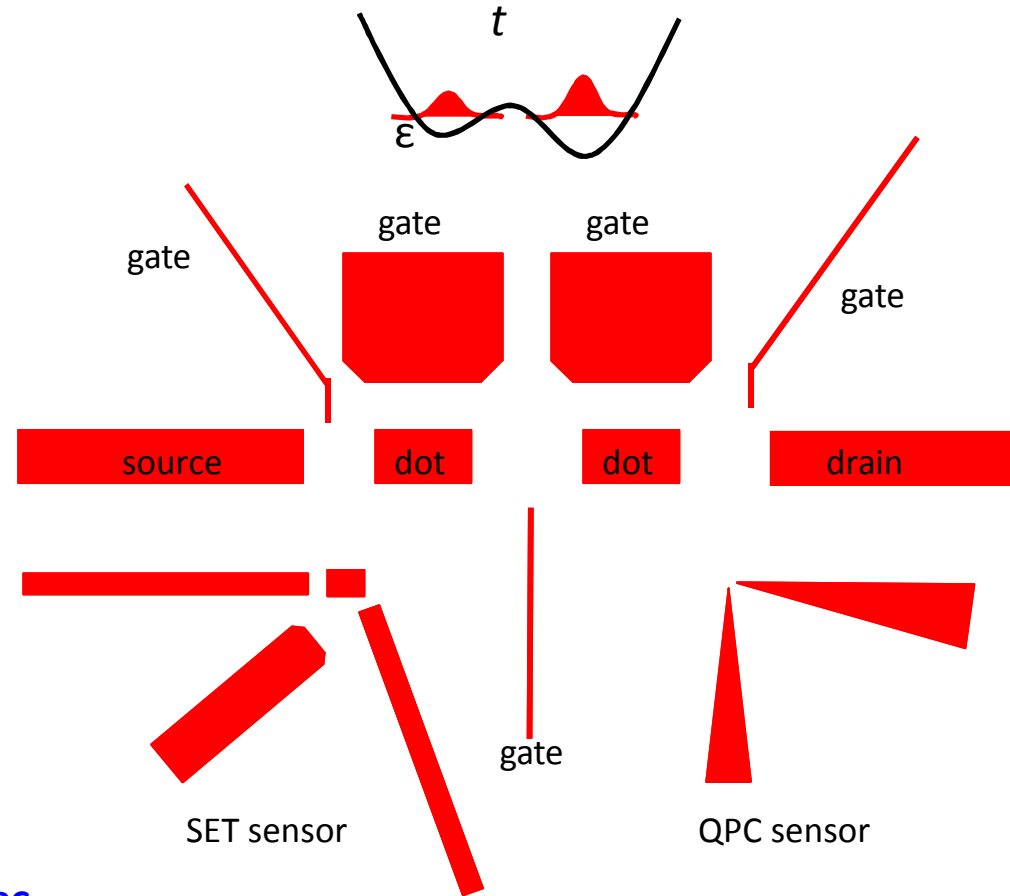
Preparing initial qubit designs

Brainstorm on what we need for device

(4/2012-6/2012)

1. Tunable tunnel barriers
(ideally tunnel rates from 0 to $>10^9$ Hz)
1. Tunable ϵ and dot occupation—few electron
3. A charge sensor

Tunable potential wells
Separated by tunable tunnel barrier



Charge qubit components

1. Quantum dots (possibly single donor)
2. Source/drain leads
3. Tunneling gaps
4. Gates
 - Plungers to tune chemical potentials (definitely)
 - Barrier gates to tune tunnel barriers/rates
5. A passive charge-state readout circuit e.g. SET or QPC

All elements are coplanar → crowding limits number of device elements

Approach to qubit design

- Identify necessary components for the qubit
- Study Simmons devices and tabulate design rules for device components
 - feature sizes and layouts
 - mutual capacitances
 - gate lever arms
 - gate voltage ranges (leakage limits)
 - tunneling rate estimates (source-dot-drain, dot-dot)
 - charge sensor design and layout
- Identify initial design rules and also potential design challenges/issues for a charge qubit device
 - Optimal feature size and position for good coupling strengths (capacitive and tunnel couplings)
 - Charge sensing, readout QPC versus SET
 - Crowding of device elements in plane
 - Crowding of metal leads on top surface
 - Power dissipation (joule heating, electrons are moving in confined spaces) and dot leading to temperature variation
 - For a 27-nm-wide wire, 100 nA current threshold for heating (Ruess PRB 2007)
 - For 5 nm wide wire expect about 20 nA upper bound on current
- Using Simmons designs as a starting point, propose some planar designs for a few D qubit,
 - For Simmons devices, FASTCAP matches quantitatively with experimental data (predictive quantitative electrostatic modeling of proposed designs may be possible)
 - It would also be ideal to estimate tunneling rates for a given design.
(Even estimates of *relative* tunnel rates)

Qubit design starting points

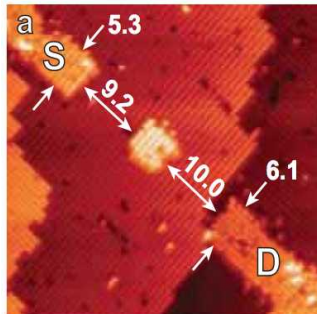
Charge qubit components

1. Quantum dots
2. Source/drain leads and tunneling gaps
3. Gates
 - Plungers to tune chemical potentials (definitely)
 - Barrier gates to tune tunnel barriers/rates
4. Charge-state readout e.g. SET or QPC

2D planar Lithographic
delta-dope devices in Si:

Design= What shape? Size?
How far apart?

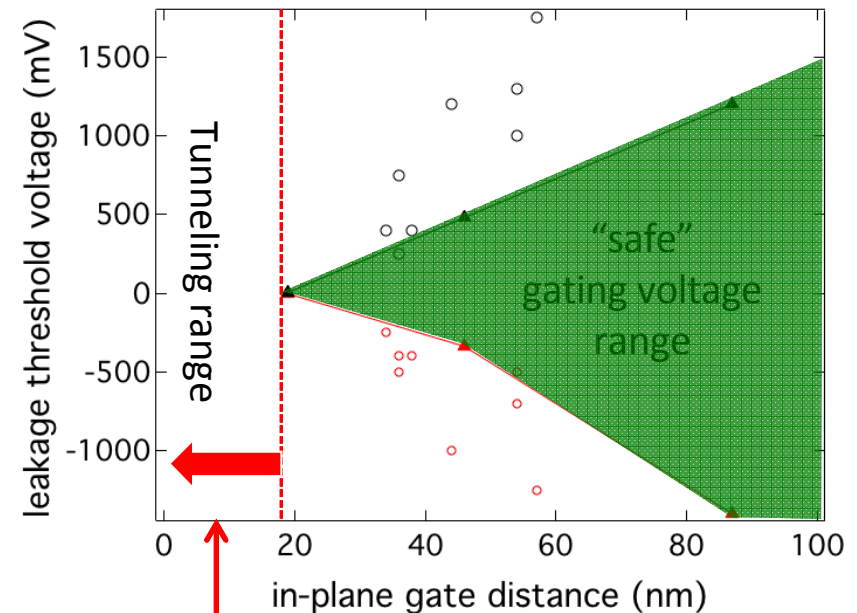
Dots: few electron



UNSW
units=nm

Source & Drain:
4-7 nm-wide lines

Gate isolation gaps:



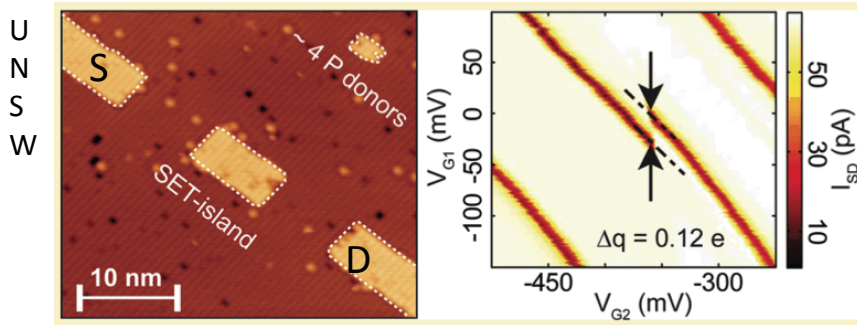
Tunnel Junctions:
8-10 nm

Charge sensor for qubit state

- SET has been demonstrated (12% charge transfer signal)
- Still no demonstration of charge sensing via QPC

Charge sense via SET

Mahapatra...Simmons Nano Lett 11, 4376 (2011)



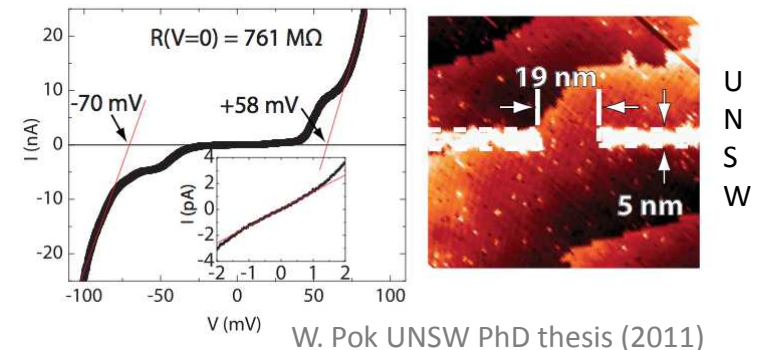
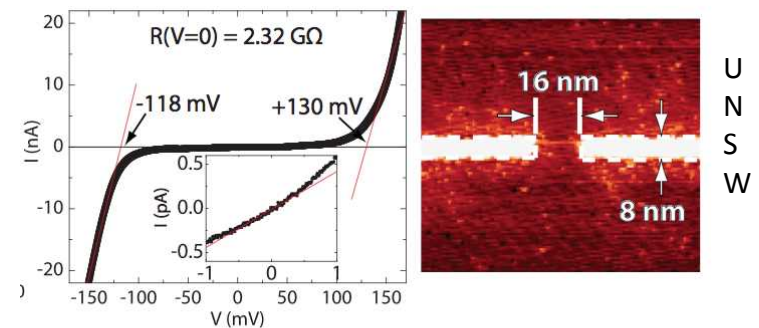
Single e^- on 4 donor dot induces
 V equivalent to $0.12 e^-$ on SET dot

→ abrupt change in SET S-D current



Charge sense via QPC (??)

Tunnel gaps have been characterized



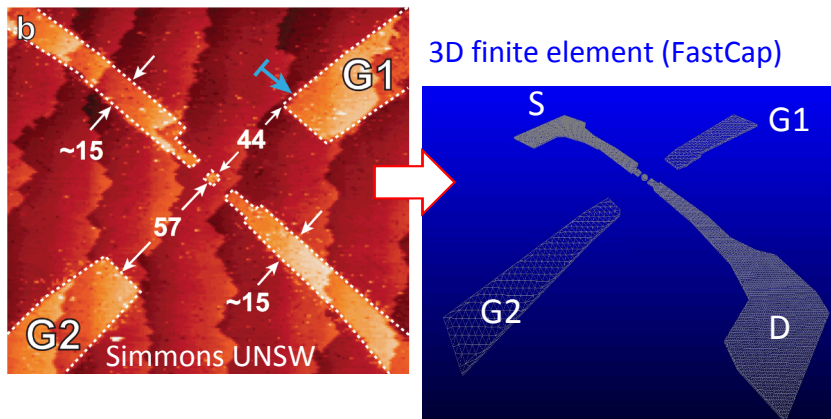
Charge sensing via QPC not yet demonstrated, QPC may require less leads

Electrostatic & transport modeling for qubit design

- Quantitative models have been demonstrated for donor devices
- NEMO (G. Klimeck): Atomistic detail, quantum properties...
- For charge qubit: use finite element models (FastCap) + transport model (CapNet)

Electrostatics modeling

6-7 donor dot (Fuechsle, Nature Nano 2010)



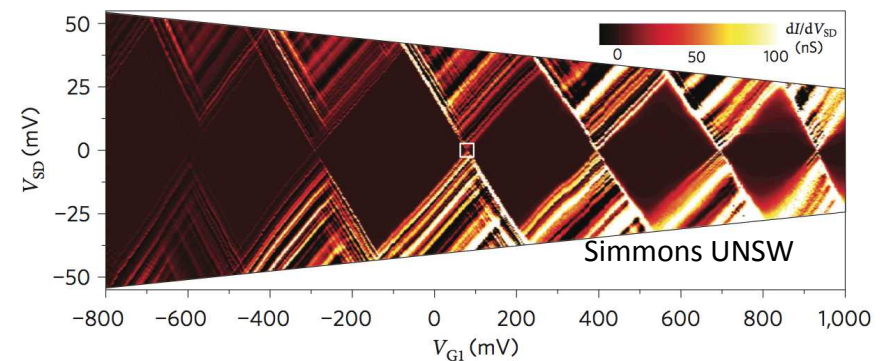
Dot capacitances (aF) & gate lever arms

| | C_S | C_D | C_{G1} | C_{G2} | α_{G1} | α_{G2} |
|------------------|-------|-------|----------|----------|---------------|---------------|
| Experiment UNSW* | 2.32 | 1.93 | 0.53 | 0.38 | 0.10 | 0.07 |
| FastCap UNSW* | 2.08 | 1.90 | 0.51 | 0.43 | 0.10 | 0.09 |
| FastCap SNL | 2.2 | 2.1 | 0.50 | 0.44 | 0.10 | 0.08 |

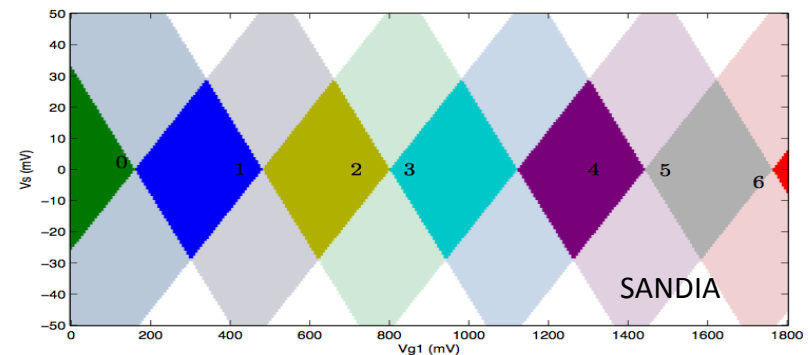
~ Quantitative agreement between model/experiment

Transport experiment and model

**In experiment, dot size depends on occupation

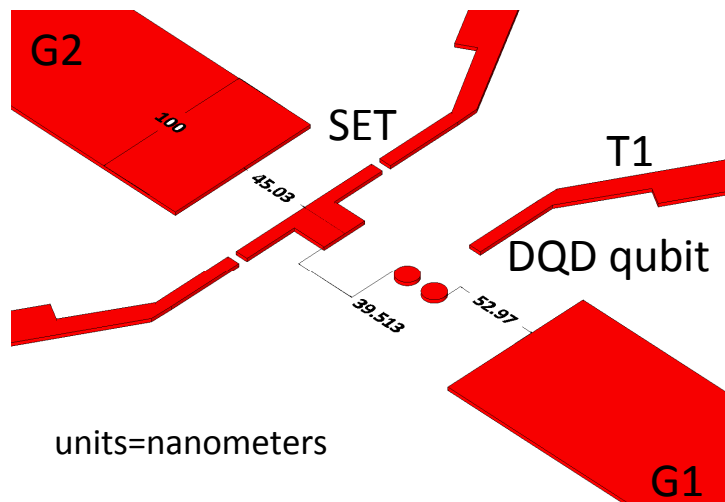


Transport (CapNet) (E. Nielsen, R. Rahman, SNL)

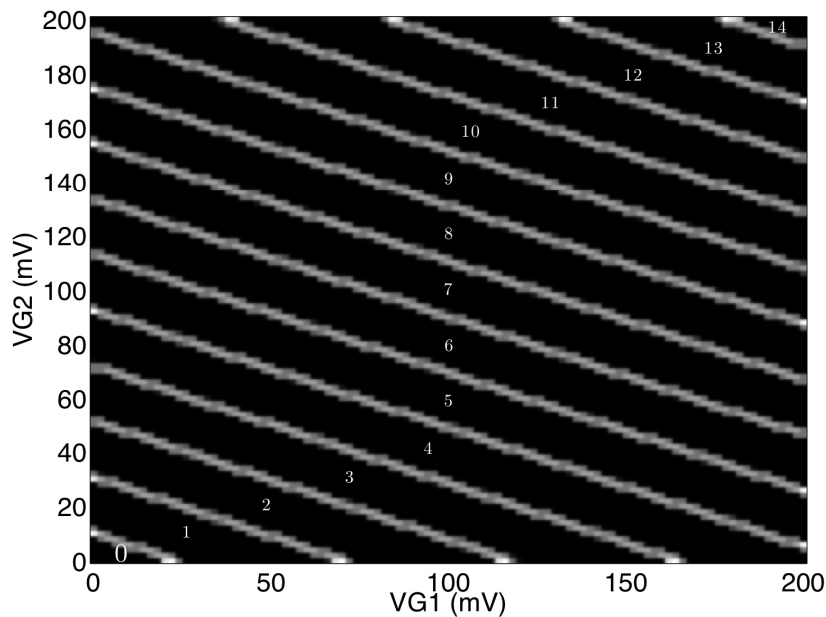


$E_c \sim 25-50$ meV vs $E_c \sim 30$ meV (Model)

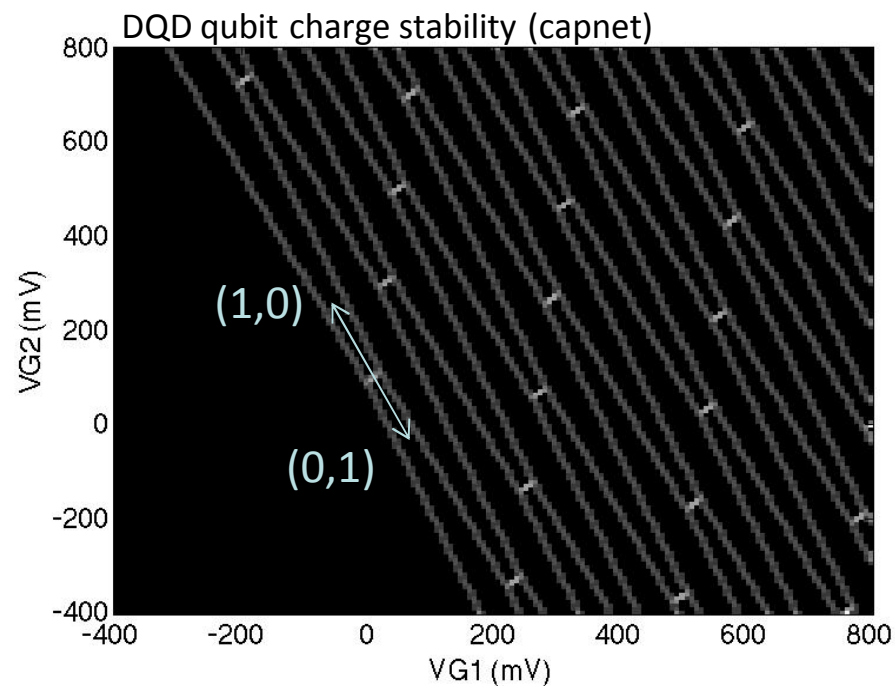
Initial charge qubit designs



Readout SET (capnet)



Charge transfer signals 3 – 6% ($\Delta VG2=0.6-1.2$ mV)



- Many DQD charge states accessible in a realistic range of $VG1$ & $VG2$
- The SET has many charge states in the same $VG1$ & $VG2$ range
- Charge transfer signals of 3-6% suggest SET will be sensitive electrometer of qubit state

Milestones for STM fab

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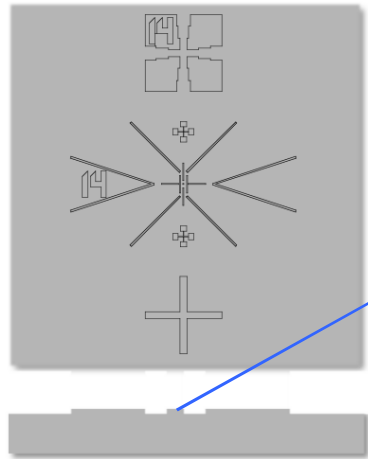
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1. Start w clean $\text{Si}(001)$

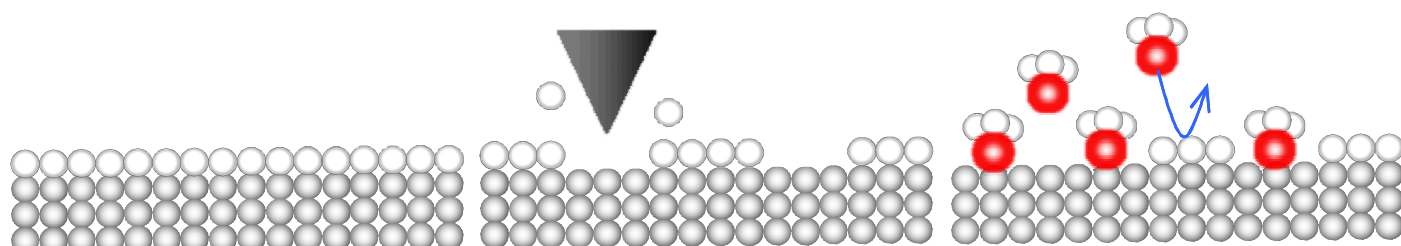
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Self-limiting 1 monolayer

3. Pattern w STM
Atomic-precision

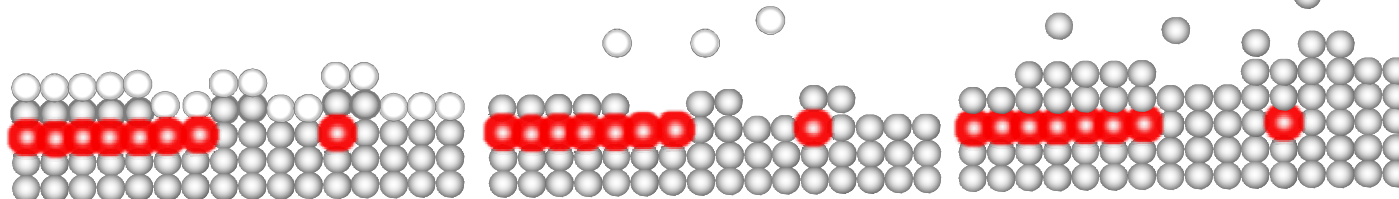
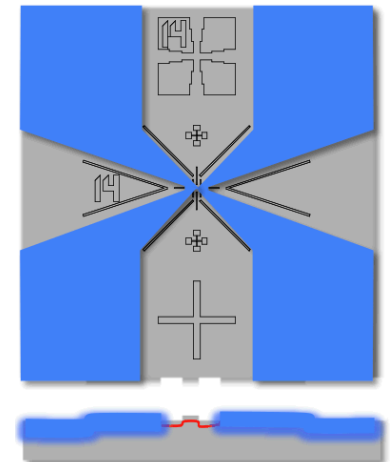
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Etched alignment marks
J. Dominguez



Al depo+liftoff
J. Dominguez



5. Incorporate P

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-H resist constrains P

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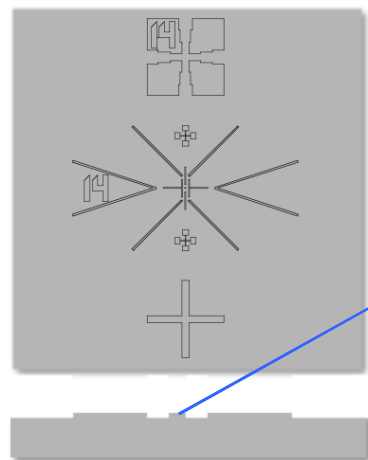
Progress on fabrication steps

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Si(001)

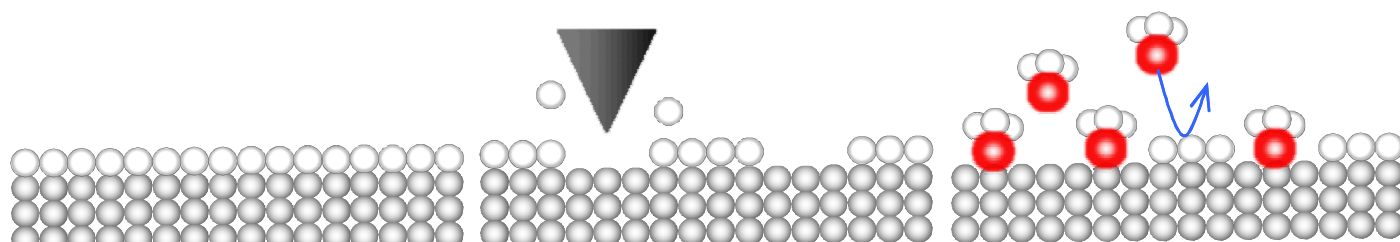
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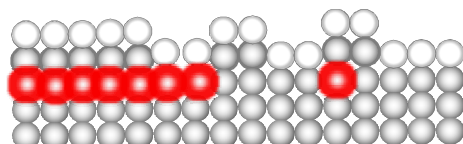
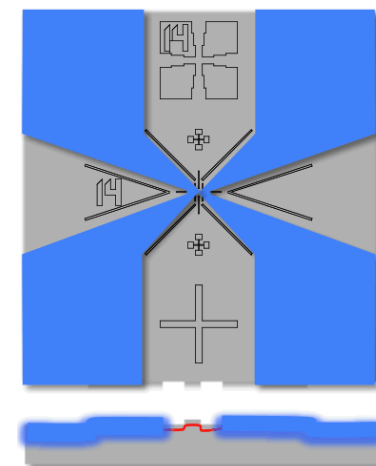
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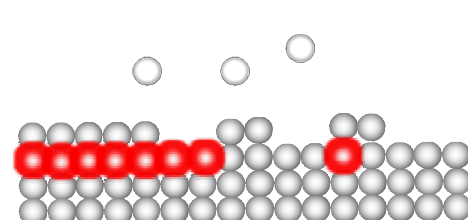
Etched alignment marks
J. Dominguez



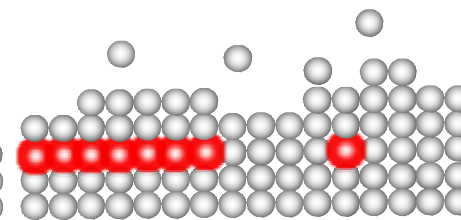
Al depo+liftoff
J. Dominguez



5. Incorporate P
-Anneal \rightarrow Si-P swap



6. Desorb H
anneal



7. Bury P in Si



8. Add contacts

Summary of work

- Completed new lab and phosphine installation & testing
- Completed new STM, installed into cleanroom lab
- Fabricated our first macroscopic test devices in the new lab
 - Performed 4K cryogenic characterization of devices
 - Demonstrated P donor incorporation and encapsulation
- With Simmons fab steps reproduced in our lab, we are working to demonstrate atomic-precision STM fabricated devices via full Simmons process
- Design and modeling of initial qubit structures in-progress

